May 2009



FDMS8680

N-Channel PowerTrench[®] MOSFET 30V, 35A, 7.0m Ω

Features

- Max $r_{DS(on)}$ = 7.0m Ω at V_{GS} = 10V, I_D = 14A
- Max $r_{DS(on)}$ = 11.0m Ω at V_{GS} = 4.5V, I_D = 11.5A
- \blacksquare Advanced Package and Silicon combination for low $r_{DS(on)}$ and high efficiency
- MSL1 robust package design
- RoHS Compliant

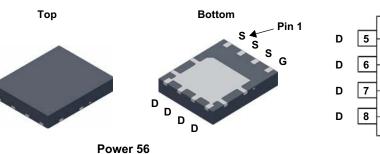


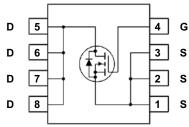
General Description

The FDMS8680 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{\text{DS}(\text{on})}$ while maintaining excellent switching performance.

Applications

- Low Side for Synchronous Buck to Power Core Processor
- Secondary Side Synchronous Rectifier
- Low Side Switch in POL DC/DC Converter
- Oring FET/ Load Switch





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25°C		35	
.	-Continuous (Silicon limited)	T _C = 25°C		63	
ID	-Continuous	T _A = 25°C	(Note 1a)	14	— A
	-Pulsed			100	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	216	mJ
Б	Power Dissipation	T _C = 25°C		50	14/
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	2.5	W
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		2.5	°C/W
R _{e.IA}	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package Reel Size Tag		Tape Width	Quantity
FDMS8680	FDMS8680	Power 56	13"	12mm	3000units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	meter Test Conditions		Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24V, V _{GS} = 0V			1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V, V _{DS} = 0V			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-5.7		mV/°C
		V _{GS} = 10V, I _D = 14A		5.5	7.0	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 11.5A$		8.5	11.0	mΩ
	$V_{GS} = 10V, I_D = 14A, T_J = 125^{\circ}C$		8.2	10.5		
9 _{FS}	Forward Transconductance	V _{DD} = 10V, I _D = 14A		72		S

Dynamic Characteristics

C _{iss}	Input Capacitance	\\ -45\\\\ -0\\	1195	1590	pF
C _{oss}	Output Capacitance	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz	555	740	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	95	145	pF
R _a	Gate Resistance	f = 1MHz	0.8	4.0	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		V_{DD} = 15V, I_{D} = 14A, V_{GS} = 10V, R_{GEN} = 6 Ω		9	18	ns
t _r	Rise Time	V _{DD} = 15V, I _D = 14			3	10	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} - 10V, K _{GEN}			21	34	ns
t _f	Fall Time				2	10	ns
Q_g	Total Gate Charge	V _{GS} = 0V to 10V			18	26	nC
Qg	Total Gate Charge	V _{GS} = 0V to 5V	V _{DD} = 15V, I _D = 14A		10	14	nC
Q _{gs}	Gate to Source Charge		1 _D = 14A		3.2		nC
Q_{gd}	Gate to Drain "Miller" Charge				2.7		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0V, I _S = 14A (Note 2)		8.0	1.2	V
t _{rr}	Reverse Recovery Time	L = 14A di/dt = 100A/vo		27	44	ns
Q _{rr}	Reverse Recovery Charge	I _F = 14A, di/dt = 100A/μs		15	27	nC

^{1.} R_{0,1} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1} is guaranteed by design while R_{0,0} is determined by the user's board design.



a. 50°C/W when mounted on a 1in² pad of 2 oz copper.



b. 125°C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300μ s, Duty cycle < 2.0%. 3. Starting T_J = 25°C, L = 3mH, I_{AS} = 12A, V_{DD} = 30V, V_{GS} = 10V.

Typical Characteristics T_J = 25°C unless otherwise noted

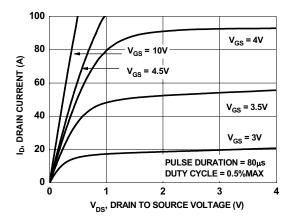


Figure 1. On-Region Characteristics

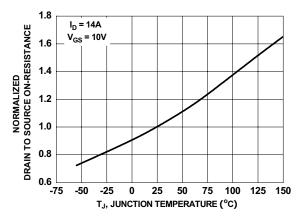


Figure 3. Normalized On-Resistance vs Junction Temperature

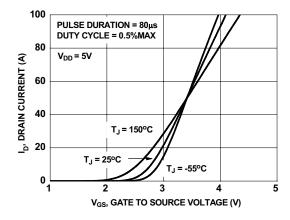


Figure 5. Transfer Characteristics

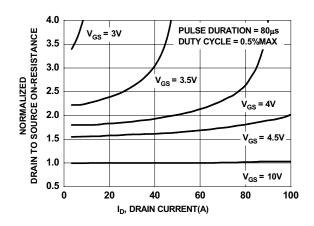


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

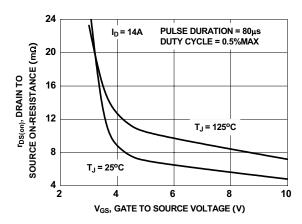


Figure 4. On-Resistance vs Gate to Source Voltage

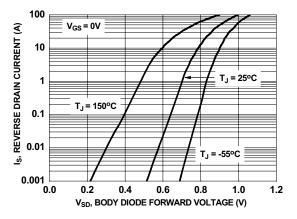


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

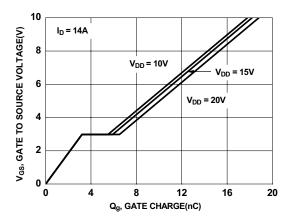


Figure 7. Gate Charge Characteristics

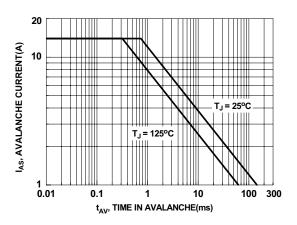


Figure 9. Unclamped Inductive Switching Capability

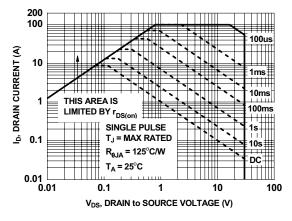


Figure 11. Forward Bias Safe Operating Area

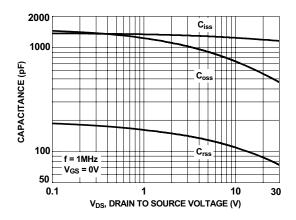


Figure 8. Capacitance vs Drain to Source Voltage

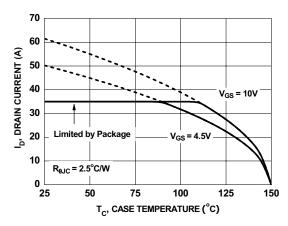


Figure 10. Maximum Continuous Drain Current vs Case Temperature

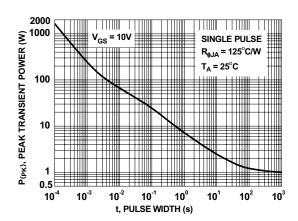


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

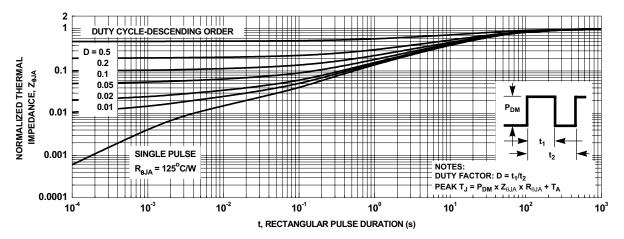


Figure 13. Transient Thermal Response Curve

Dimensional Outline and Pad Layout A 5.00 3.91 -1.27 PKG Œ В 6 8 5 0.77 4.52 PKG & 6.00 6.61 1.27 PIN #1 IDENT MAY TOP VIEW 2 3 4 APPEAR AS OPTIONAL 1.27 -0.61- 3.81 DETAIL A LAND PATTERN RECOMMENDATION SIDE VIEW OPTIONAL DRAFT ANGLE MAY APPEAR 5.00 ON FOUR SIDES 3.81 OF THE PACKAGE 1.27 0.46 0.36 (8X) (0.39)⊕ 0.10M C A B .3 \square 6.15 5.75 4.01±0.30 CHAMFER CORNER AS PIN #1 0.71 IDENT MÄY APPEAR AS **OPTIONAL** OPTIONAL TIE BARS MAY 6 APPEAR ON THESE AREAS (MAX. 3.86 3.61 TIE BAR PROTRUSION: 0.15mm) BOTTOM VIEW NOTES: UNLESS OTHERWISE SPECIFIED PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002. ALL DIMENSIONS ARE IN MILLIMETERS. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM. DIMENSIONING AND TOLERANCING PER ASME Y14.5M—1994. DRAWING FILF NAMF: POFNORAREV4 // 0.10 C ○ 0.08 C DRAWING FILE NAME: PQFN08AREV4 0.05 1.10 SEATING PLANE DETAIL A SCALE: 2:1





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